09/493,517

IEEE *Xplore* ℗
RELEASE 2.1

Welcome United States Patent and Trademark Office

:□ Search Results

BROWSE   SEARCH   IEEE XPLORE GUIDE   SUPPORT

Results for "((((extending<in>metadata) <and> (schema<in>metadata))<and> (xml<in..."
Your search matched **3** of **1331196** documents.
A maximum of **100** results are displayed, **25** to a page, sorted by **Relevance** in **Descending** order.

☑ e-mail   🖶 printer friendly

» Search Options

View Session History

New Search

» Key

IEEE JNL	IEEE Journal or Magazine
IEE JNL	IEE Journal or Magazine
IEEE CNF	IEEE Conference Proceeding
IEE CNF	IEE Conference Proceeding
IEEE STD	IEEE Standard

Modify Search

((((extending<in>metadata) <and> (schema<in>metadata))<and> (xml<in>metad [**Search**]

☐ Check to search only within this results set

Display Format: ⦿ Citation   ◯ Citation & Abstract

[**view selected items**]   **Select All Deselect All**

☐   1. **Object-Oriented mediator queries to XML data**
Lin, H.; Risch, T.; Katchaounov, T.;
Web Information Systems Engineering, 2000. Proceedings of the First International Conference on
Volume 2, 19-21 June 2000 Page(s):39 - 46 vol.2
Digital Object Identifier 10.1109/WISE.2000.882852

AbstractPlus | Full Text: PDF(536 KB)   **IEEE CNF**
Rights and Permissions

☐   2. **A generic load/extract utility for data transfer between XML documents and relational databases**
Bourret, R.; Bornhovd, C.; Buchmann, A.;
Advanced Issues of E-Commerce and Web-Based Information Systems, 2000. WECWIS 2000. Second International Workshop on
8-9 June 2000 Page(s):134 - 143
Digital Object Identifier 10.1109/WECWIS.2000.853868

AbstractPlus | Full Text: PDF(172 KB)   **IEEE CNF**
Rights and Permissions

☐   3. **The Semantic Web: the roles of XML and RDF**
Decker, S.; Melnik, S.; van Harmelen, F.; Fensel, D.; Klein, M.; Broekstra, J.; Erdmann, M.; Horrocks, I.;
Internet Computing, IEEE
Volume 4, Issue 5, Sept.-Oct. 2000 Page(s):63 - 73
Digital Object Identifier 10.1109/4236.877487

AbstractPlus | References | Full Text: PDF(144 KB)   **IEEE JNL**
Rights and Permissions

Help   Contact Us   Privacy & Security   IEEE.org

Indexed by
🛢 Inspec